



point electronic

SEM Upgrade

Referenzkunden



Cambridge S200



Hitachi S-800



Jeol T300



Leitz 1600

Kunde	Gerätetyp	Bestandteile des Upgrades
Texas Instruments GmbH D-Freisingen	SEM AmRay	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
AREVA NP GmbH D-Erlangen	SEM AmRay 1820	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - 4Q BSE Detektor - Mex Software - EDX IDFix - SDD Detektor
MAN Nutzfahrzeuge D-Nürnberg	SEM Cambridge S-200	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - X-/Y-Probenstischsteuerung - EDX IDFix - Si(Li) Detektor upgrade
Eisenwerk Sulzau-Werfen E&R Weinberger AG A-5451 Tenneck	SEM Cambridge S-250 MKIII	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX WinEDS - Eumex Detektor
Fraunhofer Institut D-München	SEM Cambridge S-250	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix
Fraunhofer Institut D-Dresden	SEM Cambridge S-260	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - X-/Y-Probenstischsteuerung - EDX IDFix
Dyckerhoff AG D-Wiesbaden	SEM Cambridge S-360	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - SEM Bedienpult - EDX IDFix
Diehl Metall Stiftung & Co. KG D-Röthenbach	SEM Cambridge S-360	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - SEM Bedienpult - EDX IDFix
Kriminaltechnisches Labor Göth D-Mayen	SEM Cambridge S-360	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - SEM Bedienpult - EDX IDFix - SDD Detektor
Mettler-Toledo GmbH Komponentenwerke CH-Nänikon	SEM Hitachi S-500	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - SEM Bedienpult
Martin-Luther-Universität Zahnmedizin D-Halle (Saale)	SEM Hitachi S-520	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - SDD Detektor
Martin-Luther-Universität FB Physik D-Halle (Saale)	SEM Hitachi S-450	- point SEM Electronic - DISS 5 (Digital Image Scanning System)

Kunde	Gerätetyp	Bestandteile des Upgrades
Heidelberg Cement AG D-Leimen	SEM Hitachi S-450 + EDX IDFix	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX IDFix- Si(Li) Detektor
Fraunhofer Institut D-Freiburg	SEM Hitachi S-800FE	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX Oxford- Si(Li) Detektor
Universität des Saarlandes D-Saarbrücken	SEM Hitachi S-800FE	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)
Team NANO D-Stuttgart	SEM Hitachi S-806FE	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)
Hermisdorfer Keramik Institut D-Hermisdorf	SEM Jeol T-200	<ul style="list-style-type: none">- point SEM Electronic minimal- DISS 5 (Digital Image Scanning System)
Berufsschule Selb II FB Werkstoffprüfung D-Selb	SEM Jeol T-200	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- 4Q BSE Detektor- EDX IDFix- Si(Li) Detektor
Keramik Institut GmbH D-Meißen	SEM Jeol T-300	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX IDFix- Si(Li) Detektor
Samsung Corning Deutschland D-Tschernitz	SEM Jeol T-330	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX IDFix- SDD Detektor
ATW GmbH D-Berlin	SEM Jeol T-330	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX IDFix- Si(Li) Detektor
Fondis Electronic FR-Guyancourt	SEM Jeol JSM-820	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- SEM Bedienpult- EDX IDFix- Si(Li) Detektor
Evonik RÖHM GmbH D-Darmstadt	SEM Jeol JSM-840A	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- SEM Bedienpult
RÖHM GmbH Plexiglas D-Darmstadt	SEM Jeol JSM-840	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- EDX IDFix- Si(Li) Detektor
SCD ERS IL-Haifa	SEM Jeol JSM-840	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)

Kunde	Gerätetyp	Bestandteile des Upgrades
Danish Technological Institute DK-Aarhus	SEM Jeol JSM-840	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
Fraunhofer Institut D-Itzeho	SEM Jeol JSM-6400	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - Si(Li) Detektor
Institut für Halbleiter- und Fest- körperphysik A-Linz	SEM Jeol JSM-6400	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
METAL RAVNE D.O.O. SI-Ravne na Koroskem	SEM Jeol JSM 35 C	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
FH Ravensburg D-Weingarten	SEM Leitz 1200	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - SDD Detektor
Ingenieurgesellschaft Meyer und Horn-Samodelkin GbR D-Rostock	2x SEM Leitz 1600	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX Röntec QX2
Universität der Bundeswehr D-Neubiberg	SEM Philips XL20	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
remX GmbH D-Bruchsal	SEM Philips XL30	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
Deutsches Zentrum für Luft- und Raumfahrt D-Braunschweig	SEM Philips 505	- point SEM Electronic - DISS 5 (Digital Image Scanning System)
Magnet-Schultz GmbH & Co. KG D-Memmingen	SEM Philips 525	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - SDD Detektor
Fondis Electronic FR-Guyancourt	SEM Philips 535	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - SEM Bedienpult - EDX IDFix
RST GmbH D-Henningsdorf	SEM Tesla BS-340	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - SDD Detektor
Universität Potsdam FB Technische Mathematik/ Chemie D-Golm (Potsdam)	SEM Tesla BS-340	- point SEM Electronic - DISS 5 (Digital Image Scanning System) - EDX IDFix - Si(Li) Detektor
GKN Driveline D-Zwickau	SEM Zeiss DSM 960	- point SEM Electronic - DISS 5 (Digital Image Scanning System)

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CAE Cadarache FR-St Paul lez Durance Cedex	Mikrosonde Cameca Camebax R	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- X-/Y-/Z-Probenstischsteuerung- WDS-Steuerung für 4 Spektrometer
Axens Ales FR-Rueil-Malmaison Cedex	Mikrosonde Cameca Camebax	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- X-/Y-/Z-Probenstischsteuerung- WDS-Steuerung für 4 Spektrometer
Forschungszentrum GmbH D-Karlsruhe	Mikrosonde Cameca Camebax	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- X-/Y-Probenstischsteuerung- WDS-Steuerung für 3 Spektrometer
Forschungszentrum GmbH D-Karlsruhe	Mikrosonde Cameca Camebax	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- X-/Y-/Z-Probenstischsteuerung- WDS-Steuerung für 4 Spektrometer- EDX IDFix- Si(Li) Detektor
SCK CEN BE-Mol	Mikrosonde Cameca Camebax	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- X-/Y-/Z-Probenstischsteuerung- WDS-Steuerung für 4 Spektrometer
Kata Leuna AG D-Leuna	Mikrosonde ARL MicroProbe SEMQ (mit 3 WDX-Spektrometern)	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- Stromstabilisator
UMICORE R&D BE-Brüssel	Mikrosonde ARL MicroProbe SEMQ 101 (mit 3 WDX-Spektrometern)	<ul style="list-style-type: none">- point SEM Electronic- DISS 5 (Digital Image Scanning System)- SEM Bedienpult- Stromstabilisator- 4Q BSE Detektor